

QUERY CONTROL FORM		RTIS USE ONLY	
Application No.	<u>10/082,500</u>	Prepared by	<u>BSH</u>
Examiner-GAU	<u>Baumeister-2815</u>	Date	<u>05-10-04</u>
		No. of queries	<u>1</u>
		Tracking Number	<u>05919080</u>
		Week Date	<u>03-15-2004</u>
			<u>IFW-E</u>

JACKET			
a. Serial No.	f. Foreign Priority	k. Print Claim(s)	p. PTO-1449
b. Applicant(s)	g. Disclaimer	l. Print Fig.	q. PTOL-85b
c. Continuing Data	h. Microfiche Appendix	m. Searched Column	r. Abstract
d. PCT	i. Title	n. PTO-270/328	s. Sheets/Figs
e. Domestic Priority	j. Claims Allowed	o. PTO-892	t. Other

SPECIFICATION		MESSAGE	
a. Page Missing		PTD-1449: Please either initial or line	
b. Text Continuity		through citations. (Two sheets) (copies	
c. Holes through Data		provided for reference.)	
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g. Brief Description			
h. Sequence Listing			
i. Appendix			
j. Amendments			
k. Other			
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Form PTO-1449

U.S. Department of Commerce, Patent and Trademark Office

Atty Docket No.

BDG005-3

Serial No.

10/082,500

INFORMATION DISCLOSURE STATEMENT

(Use several sheets if necessary)

Applicant

Cheng-Lien Chiang

Filing Date

February 25, 2002

Group Art Unit

2815

U.S. Patent Documents

*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate
C.C.	AA	5,440,231	08/1995	Sugai	324	158.1	
C.C.	AB	6,114,770	09/2000	Akram et al.	257	784	
C.C.	AC	6,353,265	03/2002	Michii	257	777	
C.C.	AD	6,369,595	04/2002	Farnworth et al.	324	755	
	AE						
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
	AM						

Foreign Patent Documents

							Translation	
		Document	Date	Country	Class	Subclass	Yes	No
C.C.	AN	JP-06097352	04/1994	Japan	H01L	23/50	X	
	AO							

Other Art (Including Author, Title, Date, Pertinent Pages, Etc.)

	AP	
	AQ	

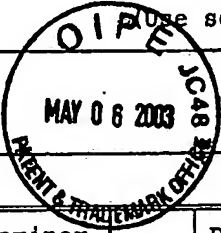
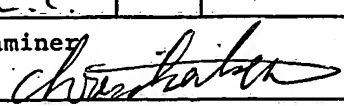
Examiner

Cheng-Lien Chiang

Date Considered

5/17/04

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Form PTO-1449 U.S. Department of Commerce, Patent and Trademark Office					Atty Docket No. BDG005-3		Serial No. 10/082,500	
INFORMATION DISCLOSURE STATEMENT (Use several sheets if necessary)					Applicant Cheng-Lien Chiang			
					Filing Date February 25, 2002		Group Art Unit 2815	
					U.S. Patent Documents			
*Examiner Initial		Document Number	Date	Name	Class	Subclass	Filing Date If Appropriate	
C.C.	AA	3,627,901	12/1971	Happ	174	52 PE		
C.C.	AB	3,678,385	07/1972	Bruner	324	158 F		
C.C.	AC	3,930,114	12/1975	Hodge	174	52 FP		
C.C.	AD	4,506,238	03/1985	Endoh et al.	333	138		
C.C.	AE	5,157,480	10/1992	McShane et al.	357	74		
C.C.	AF	5,207,102	05/1993	Takahashi et al.	73	727		
C.C.	AG	5,436,500	07/1995	Park et al.	257	696		
C.C.	AH	5,677,566	10/1997	King et al.	257	666		
C.C.	AI	5,866,939	02/1999	Shin et al.	257	666		
C.C.	AJ	5,894,107	04/1999	Lee et al.	174	52.2		
C.C.	AK	5,951,804	09/1999	Kweon et al.	156	244.12		
C.C.	AL	6,114,770	09/2000	Akram et al.	257	784		
C.C.	AM	6,130,116	10/2000	Smith et al.	438	127		
C.C.	AN	6,232,152	05/2001	DiStefano et al.	438	124		
C.C.	AO	6,297,543	10/2001	Hong et al.	257	666		
C.C.	AP	6,303,997	10/2001	Lee	257	778		
C.C.	AQ	6,326,700	12/2001	Bai et al.	257	790		
C.C.	AR	6,445,077	09/2002	Choi et al.	257	786		
C.C.	AS	6,455,356	09/2002	Glenn et al.	438	123		
C.C.	AT	6,468,836	10/2002	DiStefano et al.	438	128		
Foreign Patent Documents								
							Translation	
		Document	Date	Country	Class	Subclass	Yes	No
C.C.	AU	JP-01128897	05/1989	Japan	B42D	15/02		X
Examiner 				Date Considered 5/17/04				
<p>*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with your next communication to Applicant.</p>								

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APPLICATION NO./ CONTROL NO.	FILING DATE	FIRST NAMED INVENTOR / PATENT IN REEXAMINATION	ATTORNEY DOCKET NO.
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EXAMINER

ART UNIT	PAPER
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20040517

DATE MAILED:

Please find below and/or attached an Office communication concerning this application or proceeding.

Commissioner for Patents

The information disclosure statement filed on January 27, 2004 and May 6, 2003 have been considered because the information disclosure statement is filed before payment of the issue fee and is accompanied by the statement specified in paragraph (e) of the 37 C.F.R. 1.97 and the fee set forth in the 37 C.F.R. 1.17(p). See the attached signed copy.

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Chris C. Chu whose telephone number is 571-272-1724. The examiner can normally be reached on 11:30 - 8:00. If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Tom Thomas can be reached on 517-272-1664. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306. Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see <http://pair-direct.uspto.gov>. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

c.c.

Chris C. Chu
Examiner
Art Unit 2815

**BRADLEY BAUMISTER
PRIMARY EXAMINER**